Spring-loaded test probe

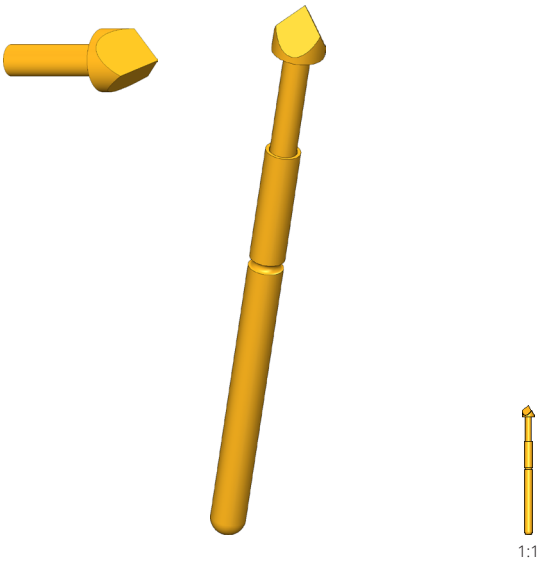
GKS-001 307 150 A 0600

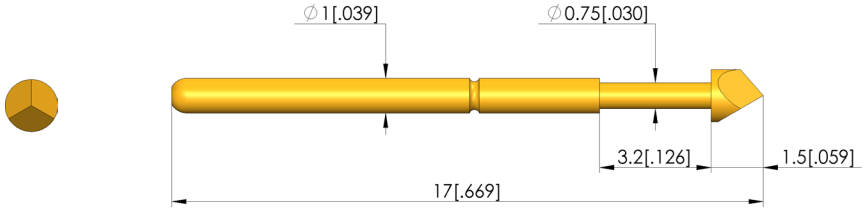
Item GKS-001-0026

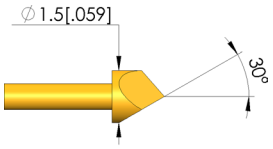
GO TO PRODUCT

ingun®
Partner for Future Technology

- Robust, compact design for harsh ICT/FCT applications with limited space
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available. spring forces.







General data

Product group:	ICT / FCT (in-circuit test and function test
Sub-product group:	Short/robust GKS
Series:	GKS-001
Grid:	1.91 mm [75 mil]
Contacting from:	Pad, via
Magnetic:	Yes
Installation type:	Plug-in
Quick-exchange system:	Yes
Adjustable installation height:	No
Non-rotating:	No
Compatible receptacle(s):	KS-001
Min. temperature:	- 40 °C [- 104 °F]
Max. temperature:	+ 80 °C [+ 176 °F]
RoHS-compliant:	RoHS-3;6c

Electrical data

Current load capacity / rated current:	3 A
Typical resistance (Ri):	<20 mOhm

Mechanical data

Total length:	17 mm [.669 in]
Barrel diameter:	1 mm [.039 in]
Maximum stroke:	3 mm [.118 in]
Spring pre-load:	0.2 N [.719 ozf]
Collar height:	00
Spring force at working stroke:	0.6 N [2.15 ozf]
Recommended working stroke:	2.4 mm [.094 in]

Tip style data

Tip style:	07 90° 3-edged chisel, self-cleaning
Tip diameter:	1.5 mm [.059 in]
Tip style surface:	A gold
Tip style material:	3 CuBe

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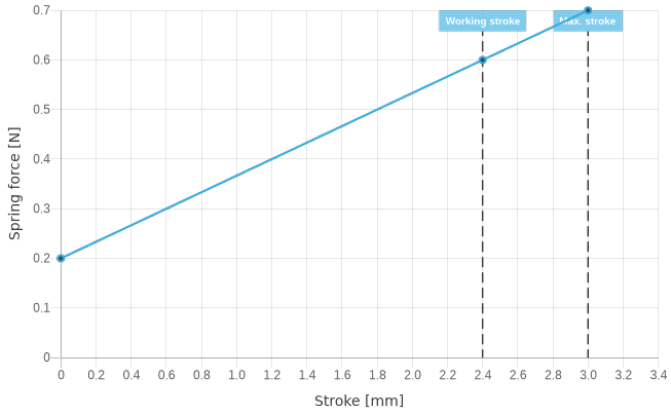

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